

## EAST Search History

## EAST Search History (Prior Art)

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
S57	1072	ETOX	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2011/03/10 15:03
S58	9	method adj ETOX	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2011/03/10 15:04
S59	612	S57 with memory	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2011/03/10 15:07
S60	100	S59 and ((control adj gate) with nitride)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2011/03/10 15:08
S61	16	S59 and ((control adj gate) with nitride with (spacer or sidewall))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2011/03/10 15:09
S62	5649	"1" and ((control adj gate) with nitride)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2011/03/10 15:11
S63	36	("4794565"   "5067108"   "5235544"   "5280446"   "5284784"   "5408115"   "5414693"   "5422504"   "5534456"   "5614747"   "5616941"   "5712179"   "5910912").PN. OR ("5991204").URPN.	US-PGPUB; USPAT; USOCR	OR	ON	2011/03/10 15:23
S65	312	(spacer near4 (control adj gate)) same oxide same nitride	US-PGPUB; USPAT	OR	ON	2011/04/21 11:08

S66	274	S65 and (floating adj gate)	US-PGPUB; USPAT	OR	ON	2011/04/21 11:10
S67	156	S66 and (@ad<"20030930" or @rlad<"20030930")	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2011/04/21 11:10
S68	4555	spacer with (smooth or smoothing or smoothed)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2011/04/21 11:38
S69	85	S68 with gate	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2011/04/21 11:39
S71	18	ETOx adj process	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2011/04/21 12:19
S72	1083	ETOx	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2011/04/21 12:26
S74	720	S72 and (floating adj gate)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2011/04/21 12:26
S75	508	S74 and (@ad<"20030930" or @rlad<"20030930")	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2011/04/21 12:27
S78	78954	control adj gate	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2011/04/21 14:09

S79	1298	(interpoly or (inter adj poly)) adj (oxide or dielectric or insulator or insulation)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2011/04/21 14:10
S80	987333	etch or etching or etched	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2011/04/21 14:11
S81	91	S78 with S79 with S80	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2011/04/21 14:11
S82	36	("4794565"   "5067108"   "5235544"   "5280446"   "5284784"   "5408115"   "5414693"   "5422504"   "5534456"   "5614747"   "5616941"   "5712179"   "5910912").PN. OR ("5991204").URPN.	US-PGPUB; USPAT; USOCR	OR	ON	2011/04/21 14:45
S83	60	S69 and (@ad<"20030930" or @rlad<"20030930")	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2011/04/21 15:01
S85	9	S83 and (control adj gate)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2011/04/21 15:05
S88	2	"6291297".pn.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2011/05/16 13:47
S89	37793	spacer with (sic or (silicon carbide))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2011/05/25 11:20

S90	16067	S89 and memory	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2011/05/25 11:21
S96	1176	spacer with (sic or (silicon adj carbide))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2011/05/25 11:25
S97	51	S96 and (control adj gate)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2011/05/25 11:25
S98	10	S97 and (@ad<"20030930" or @rlad<"20030930")	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2011/05/25 11:26
S99	2901	spacer same (sic or (silicon adj carbide))	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2011/05/25 11:30
S100	80	S99 and (control adj gate)	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2011/05/25 11:30
S102	17	S100 and (@ad<"20030930" or @rlad<"20030930")	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2011/05/25 11:31
S103	1032	spacer same (sic or (silicon adj carbide)) same oxide	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2011/05/25 11:43
S104	344	S103 and (@ad<"20030930" or @rlad<"20030930")	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2011/05/25 11:44

S105	610	257/326,E29.305.ccls.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2011/06/01 13:26
S106	65	S105 and @pd>="20100717"	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2011/06/01 13:27

**EAST Search History (Interference)**

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**6/ 1/ 2011 1:31:26 PM**

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